

Issue Classification



Application/Control No. 10500603		Applicant(s)/Patent under Reexamination OOSAWA ET AL.	
Examiner Hanan, Devin		Art Unit 3745	

ORIGINAL		INTERNATIONAL CLASSIFICATION			
CLASS	SUBCLASS	CLAIMED		NON-CLAIMED	
415	68	F 0 4 D	25 / 16		
		F 0 1 D	1 / 24		
CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
415	199.5				
416	126	198R			
Devin Hanan <i>Devin Hanan</i> (Assistant Examiner)		7/28/2006 <i>7/28/2006</i> (Date)		Total Claims Allowed: 12	
(Legal Instruments Examiner)		(Date)		O.G. Print Claim(s) 1	
		EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 <i>2/28/06</i>		O.G. Print Figure 1	